

Search Notes

Application/Control No.

10/624,670

Examiner

Shin-Lin Chen

Applicant(s)/Patent under
Reexamination

LI ET AL.

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
Updated		3/5/2007	<i>SLC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated.	3/5/2007	<i>SLC</i>